



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AOSP21307**

**30V P-Channel MOSFET**

### General Description

- Latest Advanced Trench Technology
- Low  $R_{DS(ON)}$
- High Current Capability
- RoHS and Halogen-Free Compliant

### Product Summary

$V_{DS}$	-30V
$I_D$ (at $V_{GS}=-10V$ )	-14A
$R_{DS(ON)}$ (at $V_{GS}=-10V$ )	< 11.5mΩ
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$ )	< 18.5mΩ

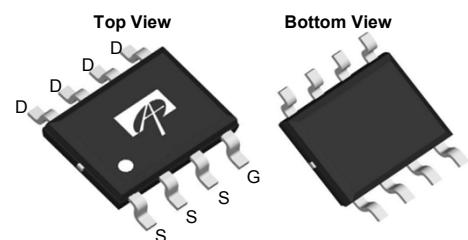
### Applications

- Notebook AC-in Load Switch
- Battery Protection Charge/Discharge

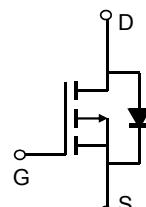
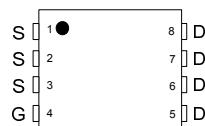
100% UIS Tested  
100%  $R_g$  Tested



SOIC-8



Top View



### Orderable Part Number

AOSP21307

### Package Type

SO-8

### Form

Tape & Reel

### Minimum Order Quantity

3000

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	V
Continuous Drain Current	$I_D$	-14	A
$T_A=70^\circ C$		-11	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	-56	
Avalanche Current <sup>C</sup>	$I_{AS}$	33	A
Avalanche energy $L=0.1\text{mH}$ <sup>C</sup>	$E_{AS}$	54	mJ
Power Dissipation <sup>B</sup>	$P_D$	3.1	W
$T_A=70^\circ C$		2.0	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	31	40	°C/W
Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State		59	75	°C/W
Maximum Junction-to-Lead	$R_{\theta JL}$	16	24	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$	-30			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=-30\text{V}$ , $V_{GS}=0\text{V}$			-1	$\mu\text{A}$
				$T_J=55^\circ\text{C}$		-5
advanced	Gate-Body leakage current	$V_{DS}=0\text{V}$ , $V_{GS}=\pm25\text{V}$				$\pm100$ nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$	-1.3	-1.8	-2.3	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}$ , $I_D=-14\text{A}$		9.5	11.5	$\text{m}\Omega$
				$T_J=125^\circ\text{C}$	13.2	15.8
		$V_{GS}=-4.5\text{V}$ , $I_D=-10\text{A}$			14.7	18.5
$g_{FS}$	Forward Transconductance	$V_{DS}=-5\text{V}$ , $I_D=-14\text{A}$			42	S
$V_{SD}$	Diode Forward Voltage	$I_S=-1\text{A}$ , $V_{GS}=0\text{V}$		-0.7	-1	V
$I_S$	Maximum Body-Diode Continuous Current				-4	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$		1995		pF
$C_{oss}$	Output Capacitance			300		pF
$C_{rss}$	Reverse Transfer Capacitance			260		pF
$R_g$	Gate resistance	$f=1\text{MHz}$		4.5	9	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-14\text{A}$		35	50	nC
$Q_g(4.5\text{V})$	Total Gate Charge			17	25	nC
$Q_{gs}$	Gate Source Charge			5.7		nC
$Q_{gd}$	Gate Drain Charge			8.8		nC
$t_{D(on)}$	Turn-On DelayTime	$V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=1.05\Omega$ , $R_{\text{GEN}}=3\Omega$		11		ns
$t_r$	Turn-On Rise Time			7.5		ns
$t_{D(off)}$	Turn-Off DelayTime			43.5		ns
$t_f$	Turn-Off Fall Time			17.5		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=-14\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$		13.3		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=-14\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$		20		nC

A. The value of  $R_{\text{QA}}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\text{QA}}$  is the sum of the thermal impedance from junction to lead  $R_{\text{JL}}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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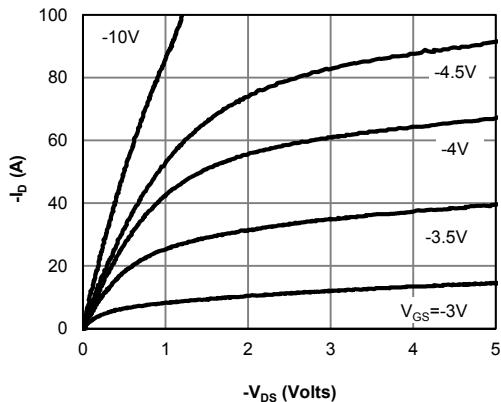
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 1: On-Region Characteristics (Note E)

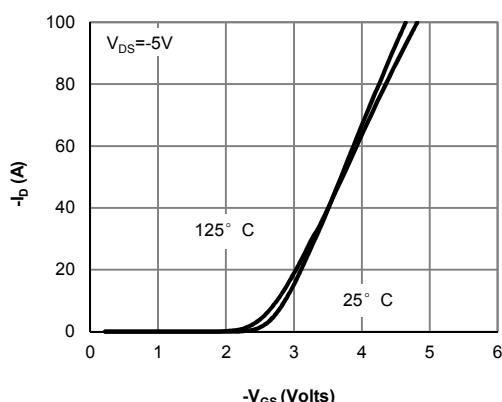


Figure 2: Transfer Characteristics (Note E)

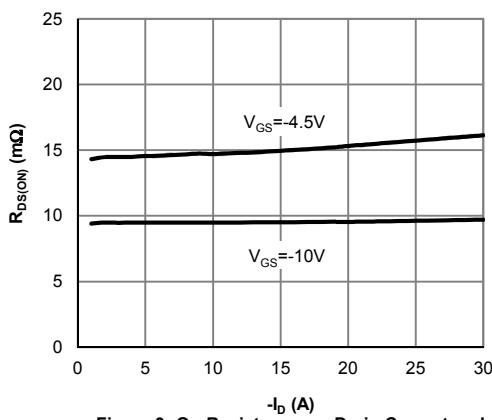


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

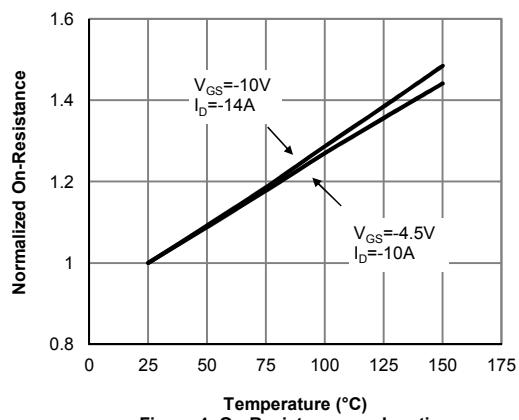


Figure 4: On-Resistance vs. Junction Temperature (Note E)

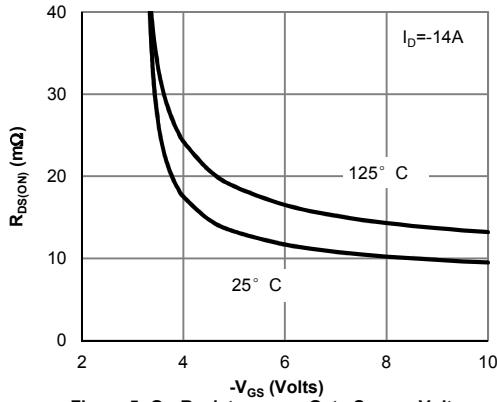


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

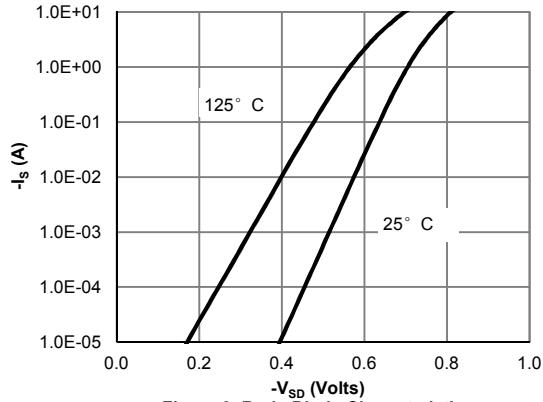


Figure 6: Body-Diode Characteristics (Note E)

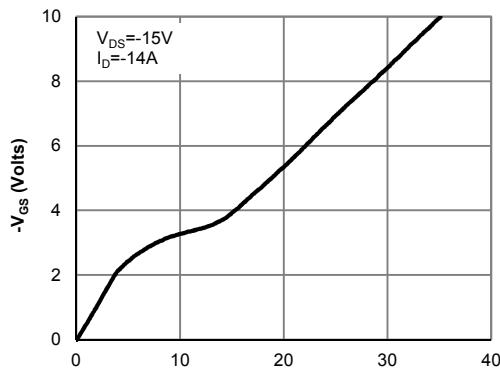
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 7: Gate-Charge Characteristics

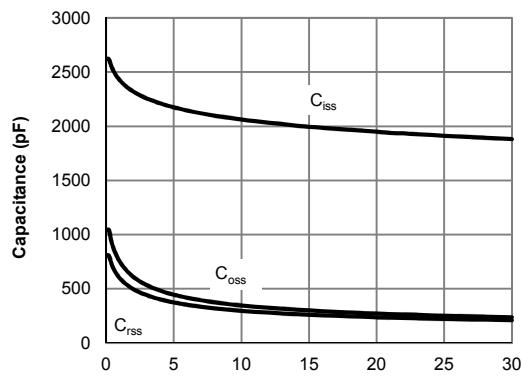


Figure 8: Capacitance Characteristics

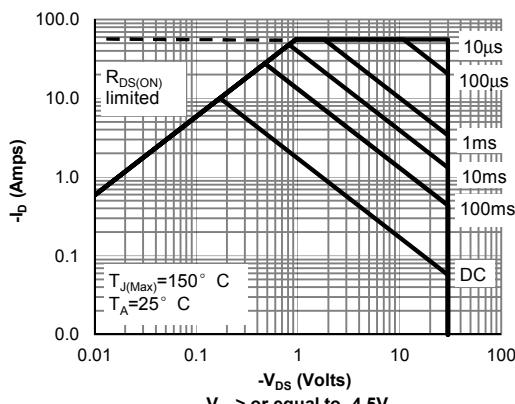


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

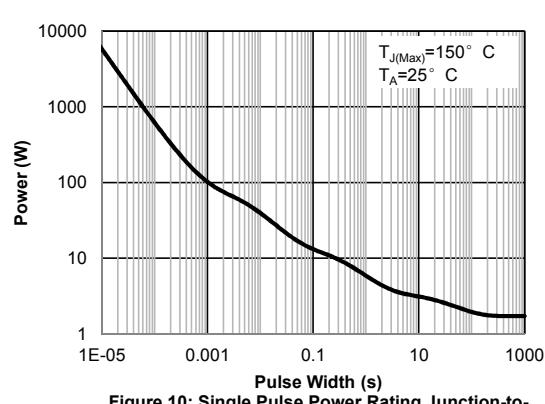


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

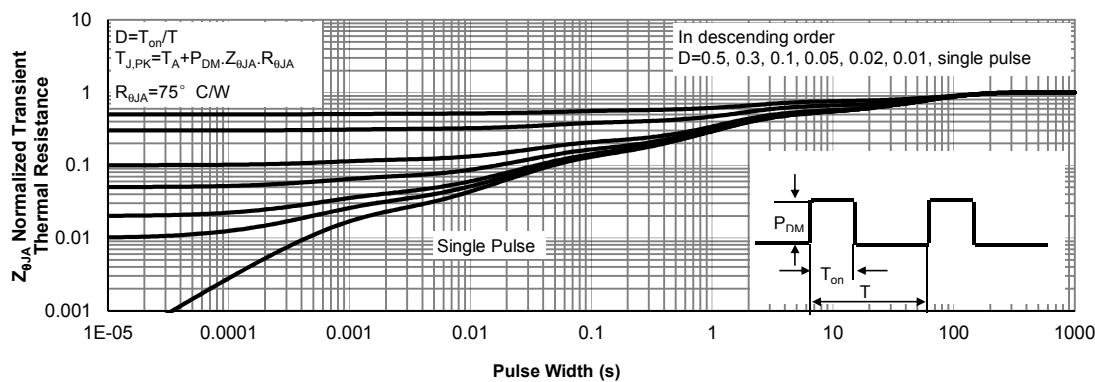
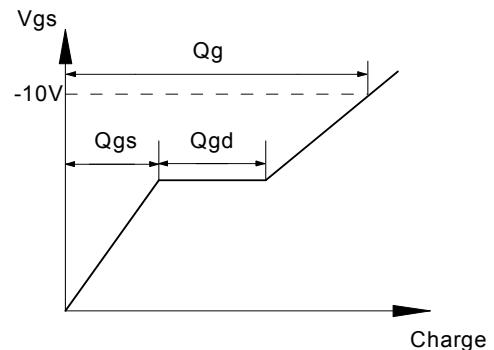
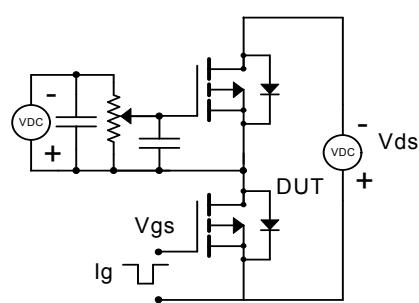
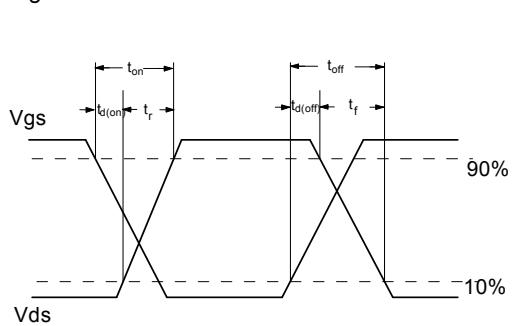
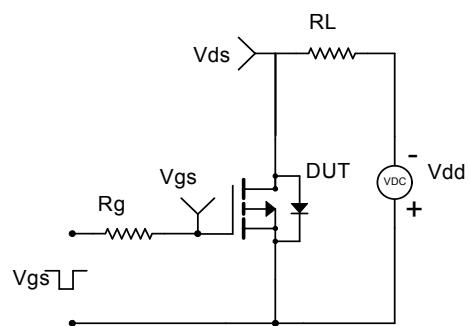


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

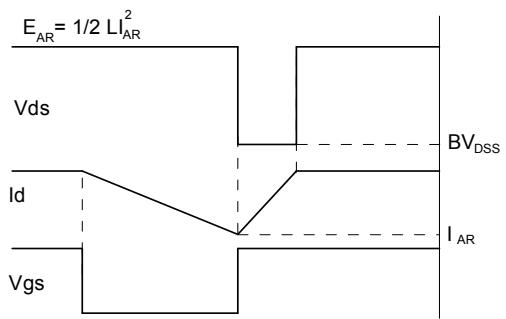
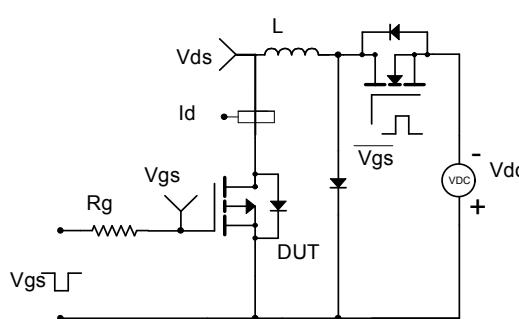
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

